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U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
	A						
	B						

Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
	C							
	D							

Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
FAA	E	"SuperComm '99: HP Launches Dedicated DWDM Test Solution", Atlanta, SuperComm '99, June 8
BAA	F	"OSA-155 DWDM System Analyzer", Wavetek Wandel Goltermann, http://fiberoptics.wwgsolutions.com/products/osa/osa155.html , 1999
BAA	G	"DWDM System Analyzer", http://www.wwgsolutions.com
BAA	H	"Launching the Q8384 Optical Spectrum Analyzer", http://www.www.advantest.co.jp/99-7-7-e.html , July 7, 1999
BAA	I	"DWDM and SONET/SDH functional test to 10 Gb/s", http://www.tm.agilent.com/tmo/TMNews/English/17-0002.html , February 2000
BAA	J	"Digital Lightwave Introduces Industry's First Integrated Portable DWDM Analyzer", http://www.lightwave.com/newspress/051700rls.htm , May 17, 2000
BAA	K	"Characterize DWDM systems in the field", http://www.tm.agilent.com/tmo/TMNews/English/02-9911.html , November 1999
BAA	L	"Understanding Dense WDM", Wavetek Wandel Goltermann, http://www.wwgsolutions.com
Examiner	Date Considered	
<i>[Signature]</i>	4/2/05	

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.